Jan 2016

SemiHow
Know-How for Semiconductor

HCP60R150T

600V N-Channel Super Junction MOSFET

Features

- Very Low FOM ($R_{DS(on)}$ X Q_g)
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested

Key Parameters

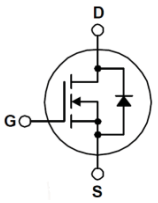
Parameter	Value	Unit
BV_{DSS} @$T_{j,max}$	650	V
I_D	22	A
$R_{DS(on),\ max}$	0.15	Ω
$Qg_{,\ Typ}$	41	nC

Application

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- TV power & LED Lighting Power

Package & Internal Circuit

TO-220



Absolute Maximum Ratings

T_C=25℃ unless otherwise specified

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	600	V
V_{GS}	Gate-Source Voltage	±30	V
I_D	Drain Current – Continuous (T_C = 25℃)	22.0	A
	Drain Current – Continuous (T_C = 100℃)	13.9	A
I_{DM}	Drain Current – Pulsed (Note 1)	60.0	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	650	mJ
P_D	Power Dissipation (T_C = 25℃)	192	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	℃
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	260	℃

Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	0.65	℃/W
$R_{\theta CS}$	Case-to-Sink	0.5	--	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

Electrical Characteristics T_J=25 °C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
On Characteristics						
V_{GS}	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA	2.0	--	4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 11 A	--	0.13	0.15	Ω
g_{FS}	Forward Transconductance	V_{DS} = 10, I_D = 11 A	--	18.8	--	S
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA	600	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 600 V, V_{GS} = 0 V	--	--	10	μA
		V_{DS} = 480 V, T_J = 125℃	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	V_{GS} = ±30 V, V_{DS} = 0 V	--	--	±100	nA
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 50 V, V_{GS} = 0 V, f = 1.0 MHz	--	1600	2100	pF
C_{oss}	Output Capacitance		--	225	295	pF
C_{rss}	Reverse Transfer Capacitance		--	14	18.5	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Time	V_{DS} = 300 V, I_D = 22 A, R_G = 25 Ω	--	48	104	ns
t_r	Turn-On Rise Time		--	108	220	ns
$t_{d(off)}$	Turn-Off Delay Time		--	176	360	ns
t_f	Turn-Off Fall Time		--	50	108	ns
Q_g	Total Gate Charge	V_{DS} = 480 V, I_D = 22 A V_{GS} = 10 V	--	41	53	nC
Q_{gs}	Gate-Source Charge		--	8	--	nC
Q_{gd}	Gate-Drain Charge		--	15	--	nC
Source-Drain Diode Maximum Ratings and Characteristics						
I_S	Continuous Source-Drain Diode Forward Current		--	--	22	A
I_{SM}	Pulsed Source-Drain Diode Forward Current		--	--	60	A
V_{SD}	Source-Drain Diode Forward Voltage	I_S = 22 A, V_{GS} = 0 V	--	--	1.2	V
trr	Reverse Recovery Time	I_S = 22 A, V_{GS} = 0 V di_F/dt = 100 A/μs	--	440	--	ns
Qrr	Reverse Recovery Charge		--	5	--	μC

Notes ;

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. I_{AS}=6A, V_{DD}=50V, R_G=25Ω, Starting T_J=25°C
3. Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%

Typical Characteristics

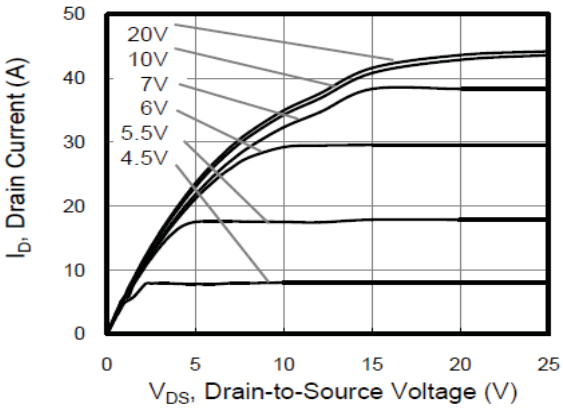


Figure 1. On Region Characteristics

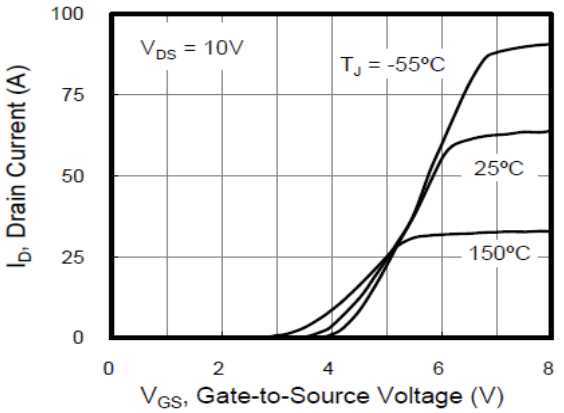


Figure 2. Transfer Characteristics

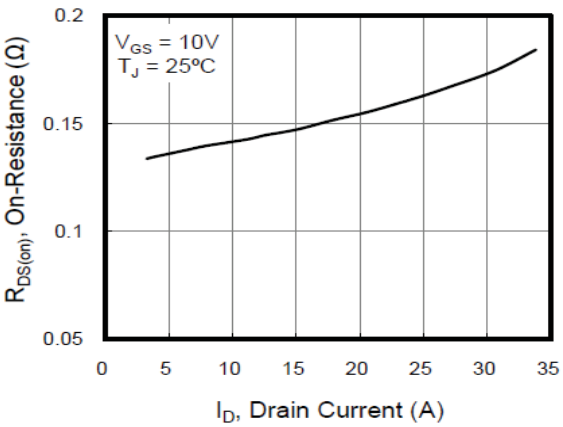


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

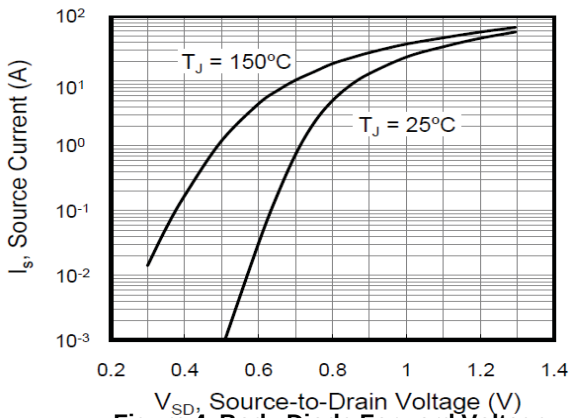


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

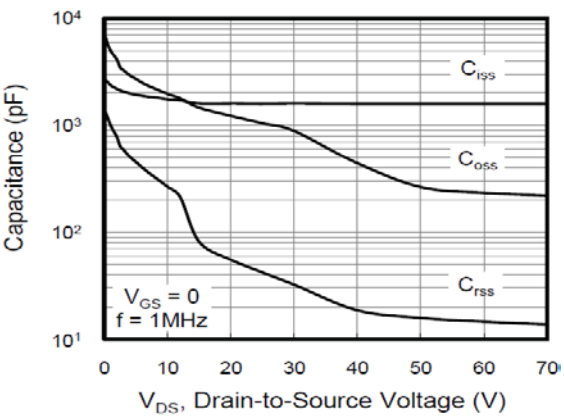


Figure 5. Capacitance Characteristics

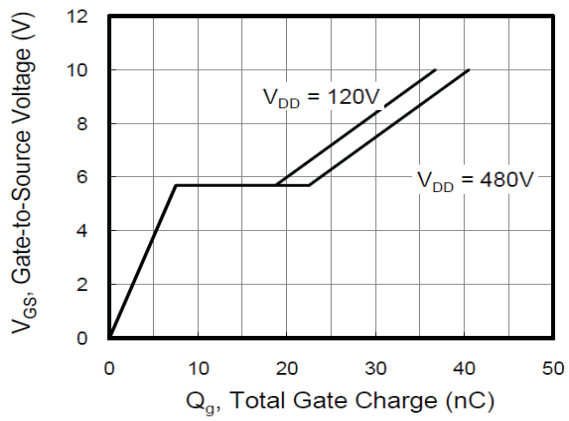


Figure 6. Gate Charge Characteristics

Typical Characteristics (continued)

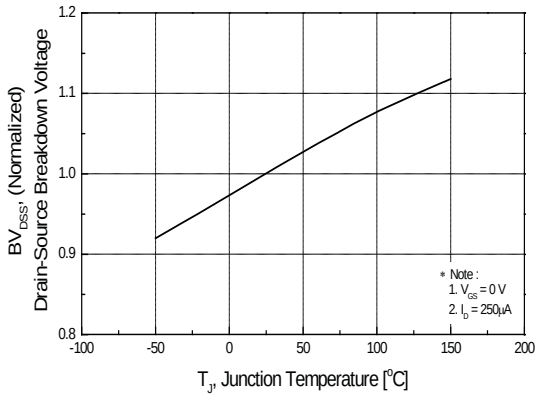


Figure 7. Breakdown Voltage Variation vs Temperature

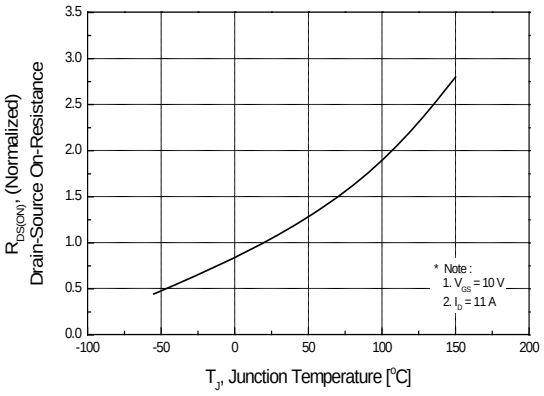


Figure 8. On-Resistance Variation vs Temperature

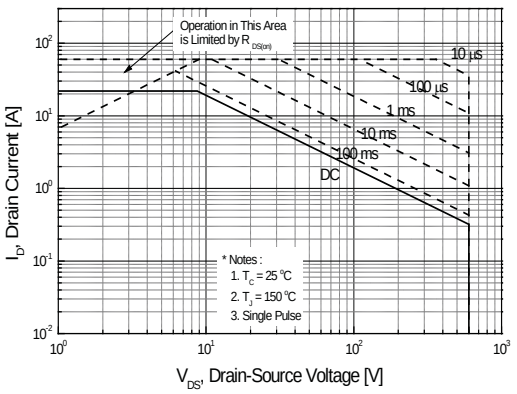


Figure 9. Maximum Safe Operating Area

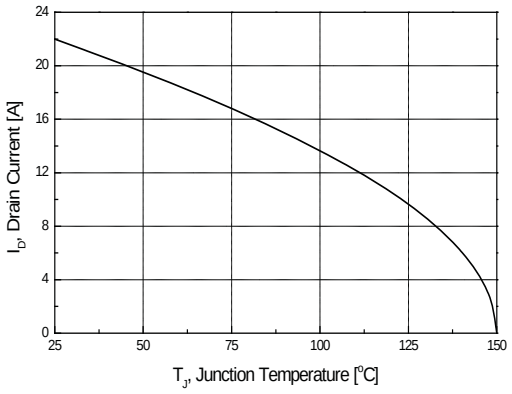


Figure 10. Maximum Drain Current vs Case Temperature

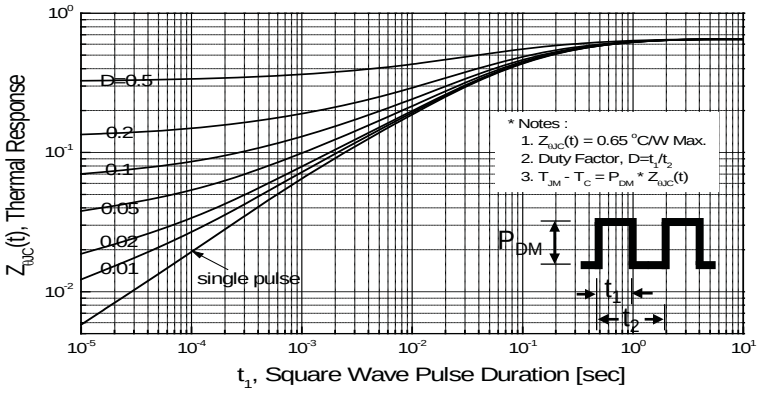


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

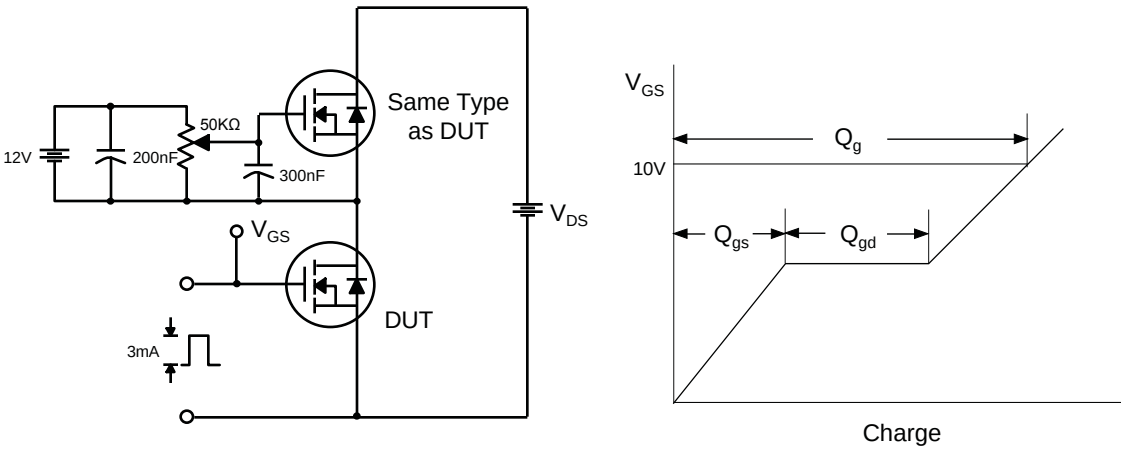


Fig 13. Resistive Switching Test Circuit & Waveforms

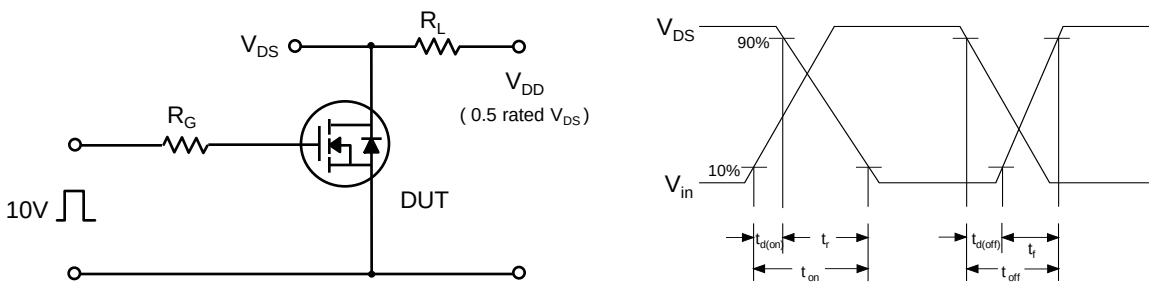


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

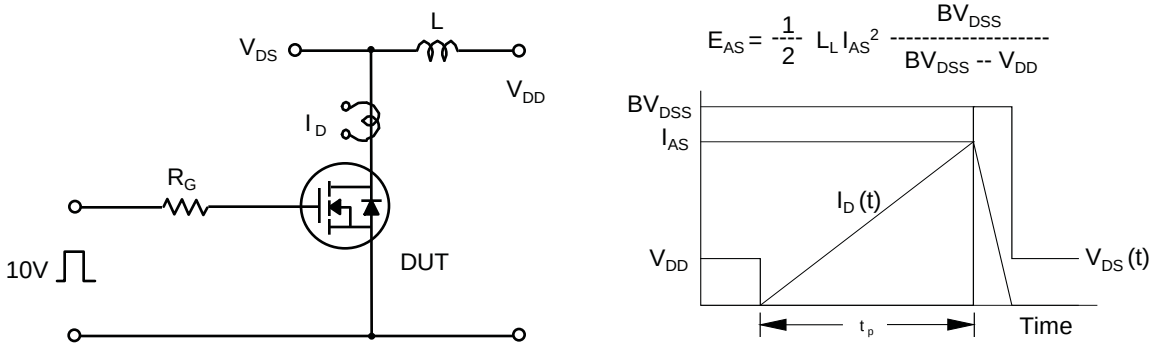
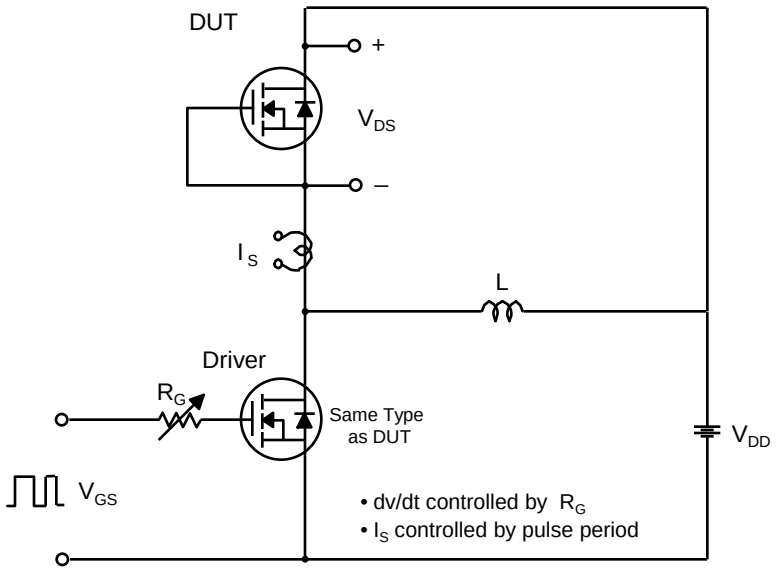
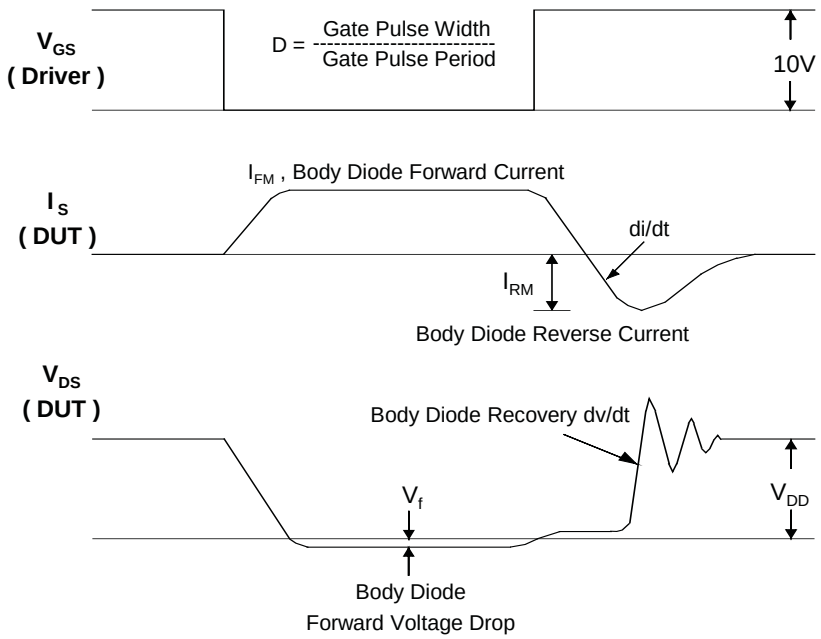


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





Package Dimension

TO-220